


<b>Search Notes</b>  	<b>Application/Control No.</b>  10587272	<b>Applicant(s)/Patent Under Reexamination</b>  NEVALAINEN ET AL.
	<b>Examiner</b>  QUN SHEN	<b>Art Unit</b>  2617

SEARCHED			
Class	Subclass	Date	Examiner
345	combined with text search	1/5/2010	QS
370	combined with text search	1/5/2010	QS
340	combined with text search	1/5/2010	QS
455	combined with text search	1/5/2010	QS
713	combined with text search	1/5/2010	QS

SEARCH NOTES		
Search Notes	Date	Examiner
Text search on EAST	1/5/2010	QS
Consult with Lunyi Lao	1/4/2010	QS
Inventor search	1/5/2010	QS

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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